MOSFET – Power, Single, N-Channel, μ8FL 30 V, 37 A

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- DC-DC Converters
- Power Load Switch
- Notebook Battery Management
- Motor Control

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Paran	Symbol	Value	Unit		
Drain-to-Source Voltage	V_{DSS}	30	V		
Gate-to-Source Voltage			V_{GS}	±20	V
Continuous Drain		T _A = 25°C	I _D	11.8	Α
Current R _{θJA} (Note 1)		T _A = 85°C		8.5	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	2.12	W
Continuous Drain		T _A = 25°C	I _D	15.9	Α
Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)		T _A = 85°C		11.5	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T _A = 25°C	P _D	3.86	W
Continuous Drain	State	T _A = 25°C	I _D	7.3	Α
Current R _{θJA} (Note 2)		T _A = 85°C		5.2	
Power Dissipation $R_{\theta JA}$ (Note 2)		T _A = 25°C	P _D	0.81	W
Continuous Drain		T _C = 25°C	Ι _D	37	Α
Current R _{θJC} (Note 1)		T _C = 85°C		27	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P _D	20.8	W
Pulsed Drain Current	rent $T_A = 25^{\circ}C, t_p = 10 \mu s$			160	Α
Operating Junction and S	T _J , T _{stg}	–55 to +150	°C		
Source Current (Body Die	I _S	20	Α		
Drain to Source dV/dt	dV/dt	6.0	V/ns		

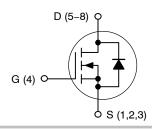


ON Semiconductor®

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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX	
30 V	9.0 mΩ @ 10 V	37 A	
	13.5 mΩ @ 4.5 V	37 A	

N-Channel MOSFET





CASE 511AB

MARKING DIAGRAM



4928 = Specific Device Code A = Assembly Location

Y = Year WW = Work Week ■ = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFS4928NTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel
NTTFS4928NTWG	WDFN8 (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Value	Unit
Single Pulse Drain-to–Source Avalanche Energy ($T_J = 25$ °C, $V_{DD} = 50$ V, $V_{GS} = 10$ V, $I_L = 20$ A _{pk} , $L = 0.1$ mH, $R_G = 25$ Ω)	E _{AS}	20	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	T_L	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

- 2. Surface-mounted on FR4 board using the minimum recommended pad size.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	6	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	59.1	
Junction-to-Ambient - Steady State (Note 4)	$R_{ heta JA}$	154.5	
Junction–to–Ambient – (t ≤ 10 s) (Note 3)	$R_{ heta JA}$	32.4	

- 3. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 4. Surface-mounted on FR4 board using the minimum recommended pad size (40 mm², 1 oz. Cu).

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
OFF CHARACTERISTICS								
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D =	: 250 μA	30			V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				24		mV/°C	
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1.0	μΑ	
		$V_{DS} = 24 \text{ V}$	T _J = 125°C			10		
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	= ±20 V			±100	nA	
ON CHARACTERISTICS (Note 5)								
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = I_{DS}$	= 250 μΑ	1.2	1.6	2.2	V	
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				3.7		mV/°C	
Drain-to-Source On Resistance	R _{DS(on)}	n) I _D = 20			5.4	9.0	mΩ	
			$V_{GS} = 10 \text{ V}$	I _D = 10 A		5.3		
		V 45V	I _D = 20 A		8.9	13.5		
		V _{GS} = 4.5 V	I _D = 10 A		8.5			
Forward Transconductance	g _{FS}	V _{DS} = 1.5 V, I _E	₎ = 15 A		40		S	
CHARGES AND CAPACITANCES								
Input Capacitance	C _{iss}				913		pF	
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 15 V			366			
Reverse Transfer Capacitance	C _{rss}				108			
Total Gate Charge	Q _{G(TOT)}				8.0		nC	
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _{DS} = 15 V, I _D = 20 A			1.6			
Gate-to-Source Charge	Q_{GS}				3.1			
Gate-to-Drain Charge	Q_{GD}				3.1			

- 5. Pulse Test: pulse width = 300 μs , duty cycle \leq 2%.
- 6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Conditi	Test Condition		Тур	Max	Unit
CHARGES AND CAPACITANCES							
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V, I _D = 20 A			16		nC
SWITCHING CHARACTERISTICS	(Note 6)	•					
Turn-On Delay Time	t _{d(on)}				9.2		ns
Rise Time	t _r	$V_{GS} = 4.5 \text{ V}, V_{DS}$	= 15 V,		25.5		1
Turn-Off Delay Time	t _{d(off)}	$V_{GS} = 4.5 \text{ V}, V_{DS}$ $I_{D} = 15 \text{ A}, R_{G} =$	3.0 Ω		14		1
Fall Time	t _f		•		4.4		1
Turn-On Delay Time	t _{d(on)}	V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			6.5		ns
Rise Time	t _r				21		1
Turn-Off Delay Time	t _{d(off)}				18		1
Fall Time	t _f				3.0		1
DRAIN-SOURCE DIODE CHARAC	TERISTICS				•	•	
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	T _J = 25°C		0.87	1.1	V
		I _S = 20 A	T _J = 125°C		0.76		1
Reverse Recovery Time	t _{RR}				21.4		ns
Charge Time	ta	$V_{GS} = 0 \text{ V, } d_{1S}/d_{1} = 0$	100 A/μs,		10.5		1
Discharge Time	t _b	$V_{GS} = 0 \text{ V, } d_{IS}/d_t = I_S = 20 \text{ A}$, ,		10.9		1
Reverse Recovery Charge	Q _{RR}	1			8.4		nC
PACKAGE PARASITIC VALUES		•	•		-		•
Source Inductance	L _S				0.38		nΗ
Drain Inductance	L _D		ľ		0.054		1
Gate Inductance	L _G	T _A = 25°C			1.3		
Gate Resistance	R _G				0.9		Ω

^{5.} Pulse Test: pulse width = 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

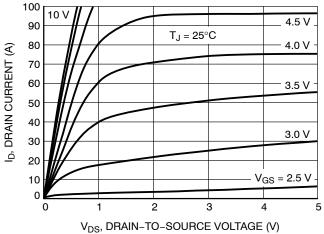


Figure 1. On-Region Characteristics

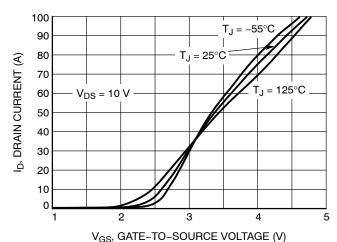


Figure 2. Transfer Characteristics

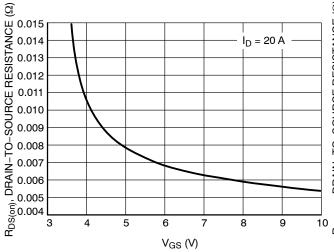


Figure 3. On-Resistance vs. V_{GS}

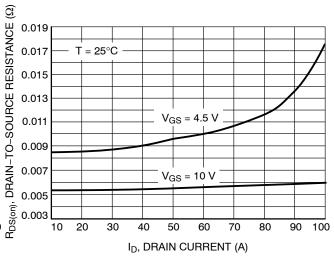


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

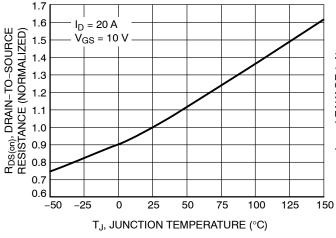


Figure 5. On–Resistance Variation with Temperature

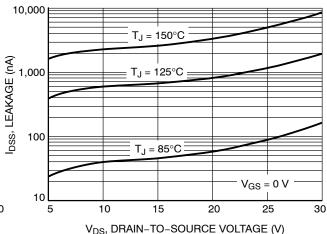


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

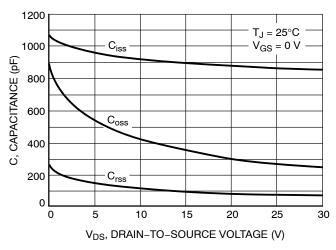


Figure 7. Capacitance Variation

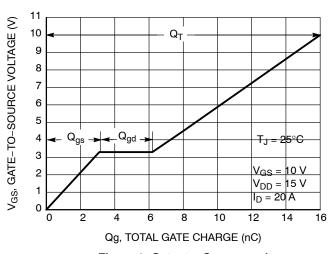


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

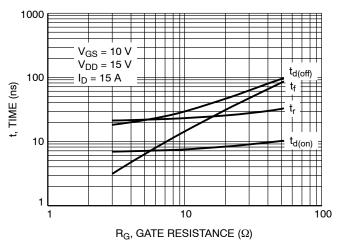


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

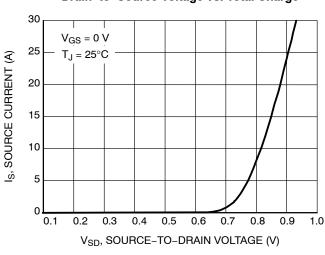


Figure 10. Diode Forward Voltage vs. Current

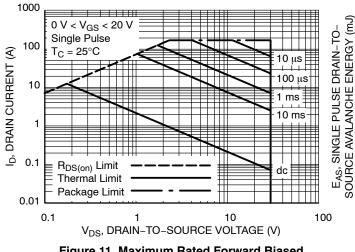


Figure 11. Maximum Rated Forward Biased Safe Operating Area

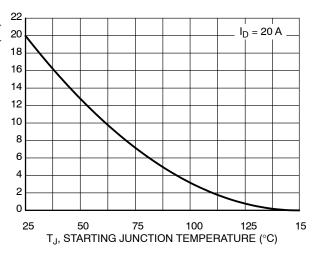


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL CHARACTERISTICS

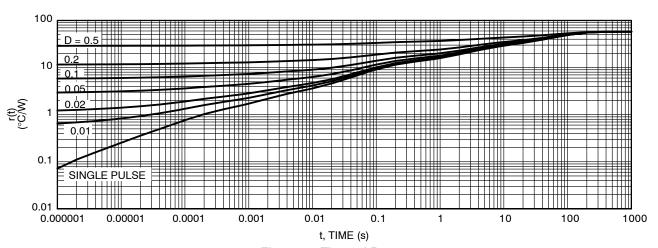


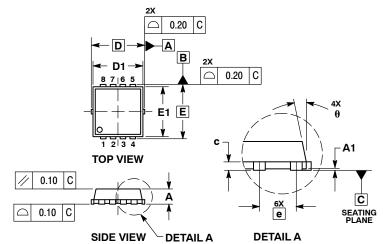
Figure 13. Thermal Response





WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

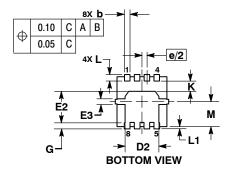
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NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

	MILLIMETERS				INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D		3.30 BSC		0	.130 BSC	;	
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
E		3.30 BSC		0	0.130 BSC		
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е		0.65 BSC	;	(0.026 BS	0	
G	0.30	0.41	0.51	0.012	0.016	0.020	
K	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
М	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	

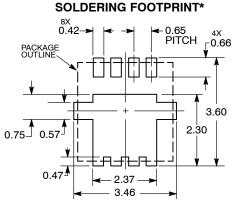


GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week = Pb-Free Package



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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